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#### November 2013



## FCP380N60 / FCPF380N60 N-Channel SuperFET<sup>®</sup> II MOSFET 600 V, 10.2 A, 380 mΩ

#### Features

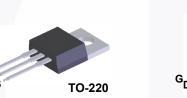
- 650 V @ T<sub>J</sub> = 150°C
- Typ. R<sub>DS(on)</sub> = 330 mΩ
- Ultra Low Gate Charge (Typ. Q<sub>a</sub> = 30 nC)
- Low Effective Output Capacitance (Typ. C<sub>oss(eff.)</sub> = 95 pF)
- 100% Avalanche Tested
- RoHS Compliant

### Applications

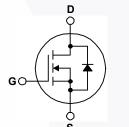
- LCD / LED / PDP TV Lighting
- Solar Inverter
- AC-DC Power Supply

## Description

SuperFET<sup>®</sup> II MOSFET is Fairchild Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET II MOSFET is very suitable for the switching power applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications.







#### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

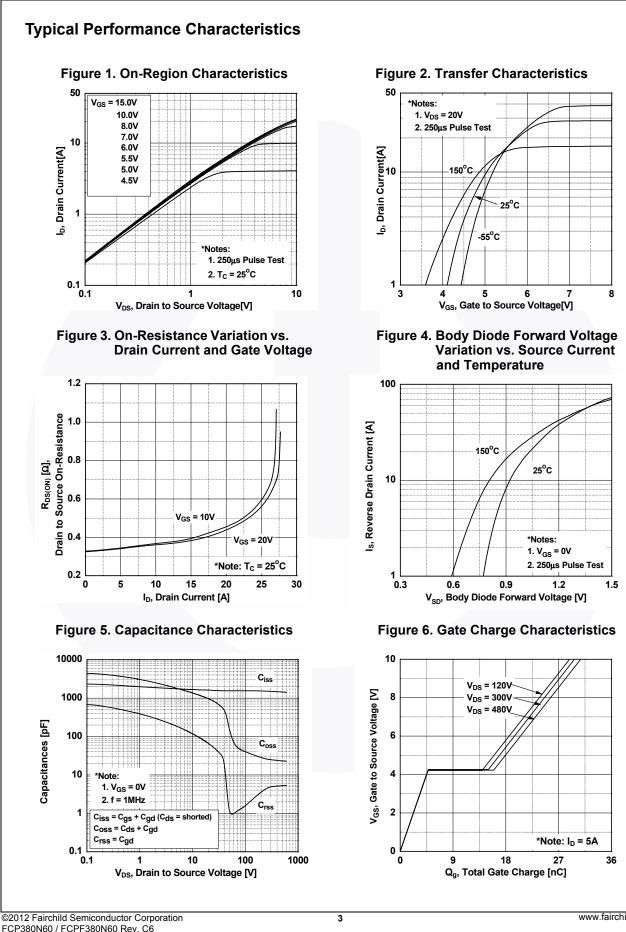
Symbol		FCP380N60	FCPF380N60	Unit		
V <sub>DSS</sub>	Drain to Source Voltage		6	V		
V <sub>GSS</sub>	Cata ta Cauraa Maltana	- DC	- DC - AC (f > 1 Hz)			V
	Gate to Source Voltage	- AC				
I <sub>D</sub>	Desia Ormant	- Continuous (T <sub>C</sub> = 25 <sup>o</sup> C)	10.2	10.2*	А	
	Drain Current	- Continuous (T <sub>C</sub> = 100 <sup>o</sup> C)	6.4	6.4*		
DM	Drain Current	- Pulsed	(Note 1)	30.6 30.6*		А
AS	Single Pulsed Avalanche En	(Note 2)	21	mJ		
AR	Avalanche Current	(Note 1)	2.3		А	
AR	Repetitive Avalanche Energ	(Note 1)	1.	1.06		
dv/dt	MOSFET dv/dt	1	Maa			
	Peak Diode Recovery dv/dt	(Note 3)	20		V/ns	
P <sub>D</sub>	Dewen Dissingtion	$(T_{C} = 25^{\circ}C)$	$(T_{\rm C} = 25^{\rm o}{\rm C})$			W
	Power Dissipation		0.85	0.25	W/ºC	
Г <sub>Ј</sub> , Т <sub>STG</sub>	Operating and Storage Temperature Range			-55 to	°C	
ſL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds			3	°C	
Drain curren	limited by maximum junction tem	perature.				

#### **Thermal Characteristics**

Symbol	Parameter	FCP380N60	FCPF380N60	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	1.18	4	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	62.5	°C/VV

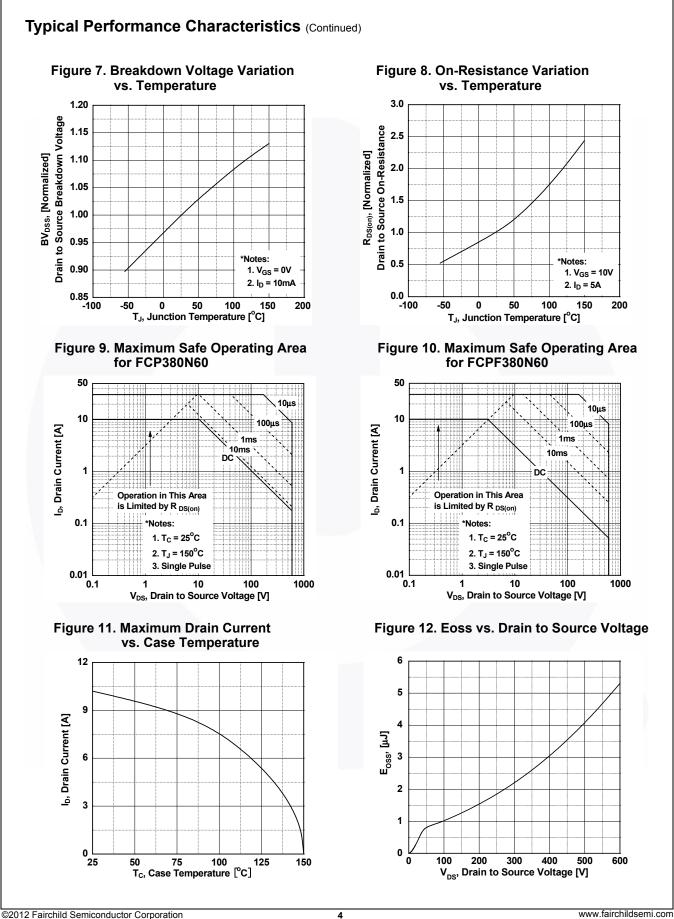
N60 N60	FCP380N60		age	Packing Method	Reel Size	Тар	e Width	Qua	incity
N60		TO-2	20	Tube	N/A	N/A		50 units	
1			20F Tube N/A			N/A		50 units	
Chara	cteristics T <sub>c</sub> = 2	5 <sup>0</sup> C unles	es oth	envise noted		1			
	Parameter	o o unice	5 011	Test Conditio	ons	Min.	Тур.	Max.	Unit
teristics			1				, ,,,		
			V	$a_0 = 0 V I_0 = 10 mA$	T, = 25°C	600	_	_	1
Drain to Source Breakdown Voltage		age	00 2 0			-	650	-	V
Breakdown Voltage Temperature		e				_	0.6		V/ºC
		akdown					700		v
Voltage					_	700	-	v	
Zero Gate Voltage Drain Current			V <sub>DS</sub> = 480 V, V <sub>GS</sub> = 0 V		-	-	1	μA	
						-	-	-	· ·
Gate to Body Leakage Current			V	$_{\rm SS}$ = ±20 V, V <sub>DS</sub> = 0 V	/	-	-	±100	nA
teristics									
Gate Thr	eshold Voltage	_	V	<sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250 μA	4	2.5	-	3.5	V
Static Dra				$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 5 \text{ A}$ $V_{DS} = 20 \text{ V}, \text{ I}_{D} = 5 \text{ A}$			0.33	0.38	Ω
Forward Transconductance			V				11	-	S
haracte	ristics								
		-				-	1250	1665	pF
					-			pF	
			f =	= 1 MHz	-	-			pF
	•		V	= 380 V. V <sub>CS</sub> = 0 \	/. f = 1 MHz	-	23	-	pF
						-	95	-	pF
			V <sub>DS</sub> = 380 V, I <sub>D</sub> = 5 A,		-	30	40	nC	
	o Source Gate Charge o Drain "Miller" Charge				-	5	-	nC	
Gate to D			(Note 4)			-	10	-	nC
Equivale							1	-	Ω
Characte	eristics								
1							14	38	ns
	n-On Rise Time n-Off Delay Time		V	V <sub>DD</sub> = 380 V, I <sub>D</sub> = 5 A,					ns
				$V_{GS}$ = 10 V, $R_{G}$ = 4.7 $\Omega$					ns
									ns
									TIC
1		ource Dic	ode Fo	orward Current		-	-	10.2	A
							-	30.6	A
Drain to S	Source Diode Forward	Voltage	V	<sub>3S</sub> = 0 V, I <sub>SD</sub> = 5 A		-	-	1.2	V
	e Recovery Time			$V_{GS} = 0 V, I_{SD} = 5 A,$			240	-	ns
	Recovery Charge			$_{\rm F}/{\rm dt} = 100 {\rm A}/{\rm \mu s}$		-	2.7	-	μC
	Drain to S Breakdow Coefficien Drain to S Voltage Zero Gat Gate to E Ceristics Gate Thr Static Dra Forward haracter Input Cap Output C Reverse Output C Effective Total Gat Gate to E Equivalen Character Turn-On Turn-Off Turn-Off Turn-Off Turn-Off Maximum	Breakdown Voltage Temperature Coefficient Drain to Source Avalanche Breat Voltage Zero Gate Voltage Drain Curren Gate to Body Leakage Current <b>teristics</b> Gate Threshold Voltage Static Drain to Source On Resis Forward Transconductance <b>haracteristics</b> Input Capacitance Output Capacitance Output Capacitance Effective Output Capacitance Output Capacitance Effective Output Capacitance Total Gate Charge at 10V Gate to Source Gate Charge Gate to Drain "Miller" Charge Equivalent Series Resistance <b>Characteristics</b> Turn-On Delay Time Turn-On Rise Time Turn-Off Fall Time <b>Ce Diode Characteristics</b> Maximum Continuous Drain to S Maximum Pulsed Drain to Source	Drain to Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Drain to Source Avalanche Breakdown Voltage Zero Gate Voltage Drain Current Gate to Body Leakage Current Ceristics Gate Threshold Voltage Static Drain to Source On Resistance Forward Transconductance haracteristics Input Capacitance Output Capacitance Effective Output Capacitance Effective Output Capacitance Effective Output Capacitance Effective Output Capacitance Characteristics Turn-On Delay Time Turn-Off Delay Time Turn-Off Fall Time Ce Diode Characteristics Maximum Continuous Drain to Source Diode F	Drain to Source Breakdown Voltage       Voltage         Breakdown Voltage Temperature       Ip         Coefficient       Ip         Drain to Source Avalanche Breakdown       Voltage         Zero Gate Voltage Drain Current       Voltage         Gate to Body Leakage Current       Voltage         Gate Threshold Voltage       Voltage         Static Drain to Source On Resistance       Voltage         Forward Transconductance       Voltage         Input Capacitance       Voltage         Output Capacitance       Voltage         Output Capacitance       Voltage         Output Capacitance       Voltage         Quiput Capacitance       Voltage         Output Capacitance       Voltage         Gate to Drain "Miller" Charge       Voltage         Equivalent Series Resistance       f =         Characteristics       Voltage         Turn-On Delay Time       Voltage         Turn-Off Fall Time       Voltage         Ce Diode Characteristics       Maximum Continuous Drain to Source Diode Forward	Drain to Source Breakdown Voltage $V_{GS} = 0 \text{ V}, \text{ I}_{D} = 10 \text{ mA},$ $V_{GS} = 0 \text{ V}, \text{ I}_{D} = 10 \text{ mA},$ I_D = 10 mA, Referenced Drain to Source Avalanche Breakdown VoltageDrain to Source Avalanche Breakdown Voltage $V_{GS} = 0 \text{ V}, \text{ I}_{D} = 10 \text{ A}$ Zero Gate Voltage Drain Current $V_{GS} = 480 \text{ V}, V_{GS} = 0 \text{ V},$ $V_{DS} = 480 \text{ V}, T_C = 1250$ ( $V_{DS} = 480 \text{ V}, T_C = 1250$ Gate to Body Leakage Current $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 5 \text{ A}$ Static Drain to Source On Resistance $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 5 \text{ A}$ Forward Transconductance $V_{DS} = 25 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ f = 1 MHzInput Capacitance $V_{DS} = 25 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ f = 1 MHzOutput Capacitance $V_{DS} = 380 \text{ V}, \text{ I}_{D} = 5 \text{ A},$ Gate to Source Gate Charge $V_{DS} = 380 \text{ V}, \text{ I}_{D} = 5 \text{ A},$ Gate to Source Gate Charge $V_{DS} = 380 \text{ V}, \text{ I}_{D} = 5 \text{ A},$ Gate to Source Gate Charge $V_{DS} = 10 \text{ V}$ Gate to Drain "Miller" Charge $V_{DS} = 10 \text{ V},$ Equivalent Series Resistancef = 1 \text{ MHz}CharacteristicsTurn-On Delay Time Turn-Off Delay Time Turn-Off Fall TimeCe Diode Characteristics $V_{DD} = 380 \text{ V}, \text{ I}_D = 5 \text{ A},$ Maximum Continuous Drain to Source Diode Forward Current Maximum Pulsed Drain to Source Diode Forward Current	Drain to Source Breakdown Voltage $V_{GS} = 0 \text{ V}, \text{ I}_{D} = 10 \text{ mA}, \text{ T}_{J} = 25^{\circ}\text{C}$ Breakdown Voltage Temperature CoefficientI_D = 10 \text{ mA}, Referenced to $25^{\circ}\text{C}$ Drain to Source Avalanche Breakdown Voltage $V_{GS} = 0 \text{ V}, \text{ I}_D = 10 \text{ A}$ Variation Source Avalanche Breakdown Voltage $V_{GS} = 0 \text{ V}, \text{ I}_D = 10 \text{ A}$ Zero Gate Voltage Drain Current $V_{DS} = 480 \text{ V}, V_{GS} = 0 \text{ V}$ Zero Gate Voltage Drain Current $V_{GS} = 480 \text{ V}, V_{CS} = 125^{\circ}\text{C}$ Gate to Body Leakage Current $V_{GS} = 10 \text{ V}, \text{ I}_D = 5 \text{ A}$ Forward Transconductance $V_{DS} = 250 \text{ µA}$ Static Drain to Source On Resistance $V_{GS} = 10 \text{ V}, \text{ I}_D = 5 \text{ A}$ Forward Transconductance $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$ Output Capacitance $V_{DS} = 380 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$ Characteristics $V_{DS} = 380 \text{ V}, \text{ I}_D = 5 \text{ A}, \text{ V}_{GS} = 10 \text{ V}$ Gate to Drain "Miller" Charge $V_{DS} = 380 \text{ V}, \text{ I}_D = 5 \text{ A}, \text{ V}_{GS} = 10 \text{ V}$ Gate to Drain "Miller" Charge $V_{CS} = 10 \text{ V}, \text{ G} = 1 \text{ MHz}$ Characteristics $Turn-On \text{ Rise Time}, \text{ V}_{DD} = 380 \text{ V}, \text{ I}_D = 5 \text{ A}, \text{ V}_{GS} = 10 \text{ V}, \text{ G} = 1$	$\begin{tabular}{ c c c c c } \hline $V_{GS} = 0 V, I_D = 10 mA, T_J = 25^\circ C & 600 \\ \hline $V_{GS} = 0 V, I_D = 10 mA, T_J = 150^\circ C & - \\ \hline $I_D = 10 mA, Referenced to 25^\circ C & - \\ \hline $V_{GS} = 0 V, I_D = 10 mA, Referenced to 25^\circ C & - \\ \hline $V_{Drain to Source Avalanche Breakdown Voltage & $V_{GS} = 0 V, I_D = 10 A & - \\ \hline $V_{Drain to Source Avalanche Breakdown Voltage & $V_{GS} = 0 V, V_{GS} = 0 V & - \\ \hline $V_{DS} = 480 V, V_{GS} = 0 V & - \\ \hline $V_{DS} = 480 V, V_{CS} = 0 V & - \\ \hline $V_{DS} = 480 V, V_{CS} = 0 V & - \\ \hline $V_{DS} = 480 V, V_{CS} = 0 V & - \\ \hline $V_{DS} = 480 V, V_{CS} = 0 V & - \\ \hline $V_{DS} = 480 V, V_{CS} = 0 V & - \\ \hline $V_{DS} = 480 V, V_{CS} = 0 V & - \\ \hline $V_{DS} = 480 V, V_{CS} = 0 V & - \\ \hline $V_{DS} = 480 V, V_{DS} = 0 V & - \\ \hline $V_{DS} = 480 V, V_{DS} = 0 V & - \\ \hline $V_{DS} = 10 V, I_D = 5 A & - \\ \hline $V_{DS} = 10 V, I_D = 5 A & - \\ \hline $V_{DS} = 20 V, I_D = 5 A & - \\ \hline $Porward Transconductance & $V_{DS} = 25 V, V_{GS} = 0 V, I_D = 5 A & - \\ \hline $Porward Transconductance & $V_{DS} = 25 V, V_{GS} = 0 V, I_D = 5 A & - \\ \hline $Porward Transconductance & $V_{DS} = 380 V, I_D = 5 A, & - \\ \hline $Cutput Capacitance & $V_{DS} = 380 V, I_D = 5 A, & - \\ \hline $Cate to Drain "Miller" Charge & $V_{CS} = 10 V & - \\ \hline $Cate to Drain "Miller" Charge & $V_{CS} = 10 V & - \\ \hline $Cate to Drain "Miller" Charge & $V_{CS} = 10 V & - \\ \hline $V_{CS} = 10 V, R_G = 4.7 \Omega & - \\ \hline $Urn-On Rise Time & $V_{DD} = 380 V, I_D = 5 A, & - \\ \hline $V_{CS} = 10 V, R_G = 4.7 \Omega & - \\ \hline $Urn-Onf Feall Time & $V_{DD} = 380 V, I_D = 5 A, & - \\ \hline $V_{CS} = 10 V, R_G = 4.7 \Omega & - \\ \hline $V_{CS} = 10 V, R_G = 4.7 \Omega & - \\ \hline $V_{CS} = 10 V, R_G = 4.7 \Omega & - \\ \hline $V_{CS} = 10 V, R_G = 4.7 \Omega & - \\ \hline $V_{CS} = 10 V, R_G = 4.7 \Omega & - \\ \hline $V_{CD} = 10 O, R_G = 4.7 \Omega & - \\ \hline $V_{CS} = 10 V, R_G = 4.7 \Omega & - \\ \hline $V_{CS} = 10 V, R_G = 4.7 \Omega & - \\ \hline $V_{CS} = 10 V, R_G = 4.7 \Omega & - \\ \hline $V_{CS} = 10 V, R_G = 4.7 \Omega & - \\ \hline $V_{CS} = 10 V, R_G = 4.7 \Omega & - \\ \hline $V_{CS} = 10 V, R_G = 4.7 \Omega & - \\ \hline $V_{CS} = 10 V, R_G = 4.7 \Omega & - \\ \hline $V_{CS} = 10 V, R_G = 4.7 \Omega & - \\ \hline $V_{CS} = 10 V, R_G = 4.7 \Omega $	$\begin{tabular}{ c c c c c } \hline V_{GS} = 0 \ V, \ I_D = 10 \ mA, \ T_J = 25^\circ C & 600 & - \\ \hline V_{GS} = 0 \ V, \ I_D = 10 \ mA, \ T_J = 150^\circ C & - & 650 \\ \hline Preakdown Voltage Temperature & I_D = 10 \ mA, \ Referenced to 25^\circ C & - & 0.6 \\ \hline Drain to Source Avalanche Breakdown \\ Voltage & V_{GS} = 0 \ V, \ I_D = 10 \ A & - & 700 \\ \hline V_{GS} = 480 \ V, \ V_{GS} = 0 \ V & - & - & - \\ \hline V_{DS} = 480 \ V, \ V_{CS} = 0 \ V & - & - & - \\ \hline Cafe to Body Leakage Current & V_{GS} = 480 \ V, \ V_{CS} = 0 \ V & - & & - & - \\ \hline Cate to Body Leakage Current & V_{GS} = 480 \ V, \ V_{CS} = 0 \ V & - & - & - \\ \hline eristics & & & & & & & & & & & & & & & & & & &$	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$

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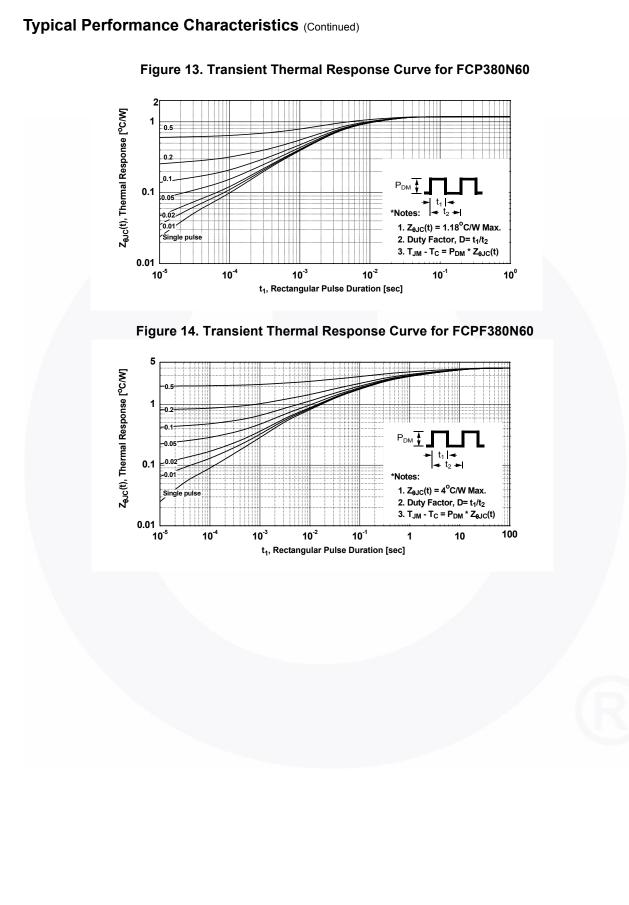


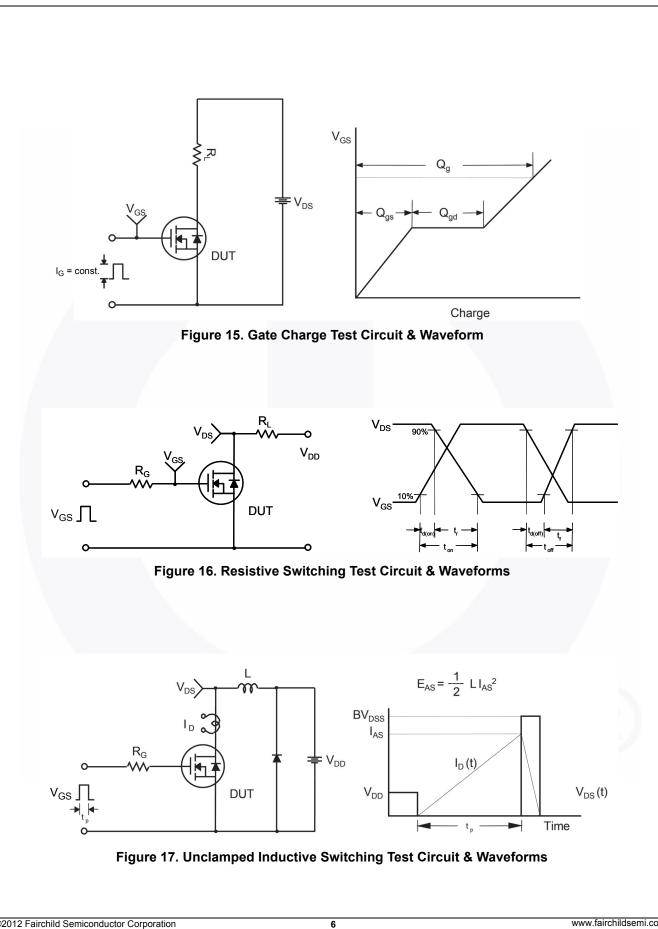
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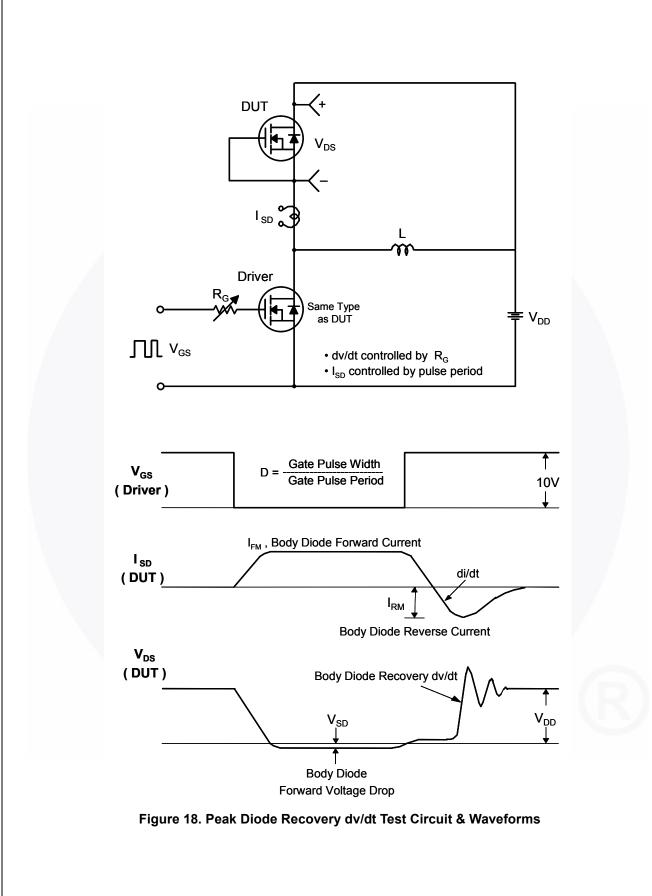
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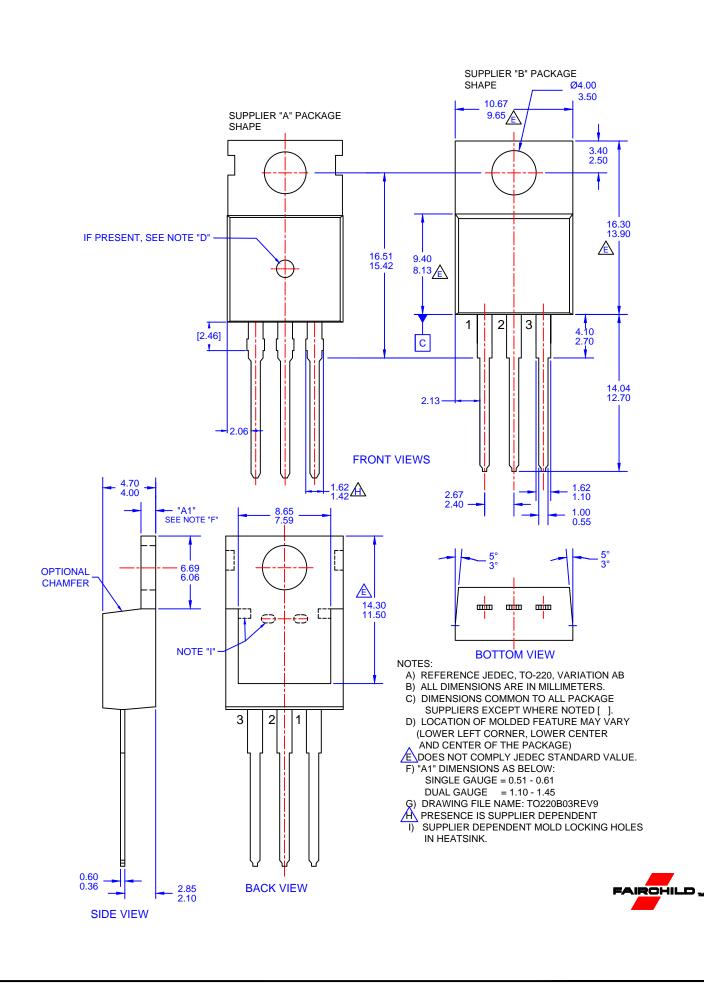


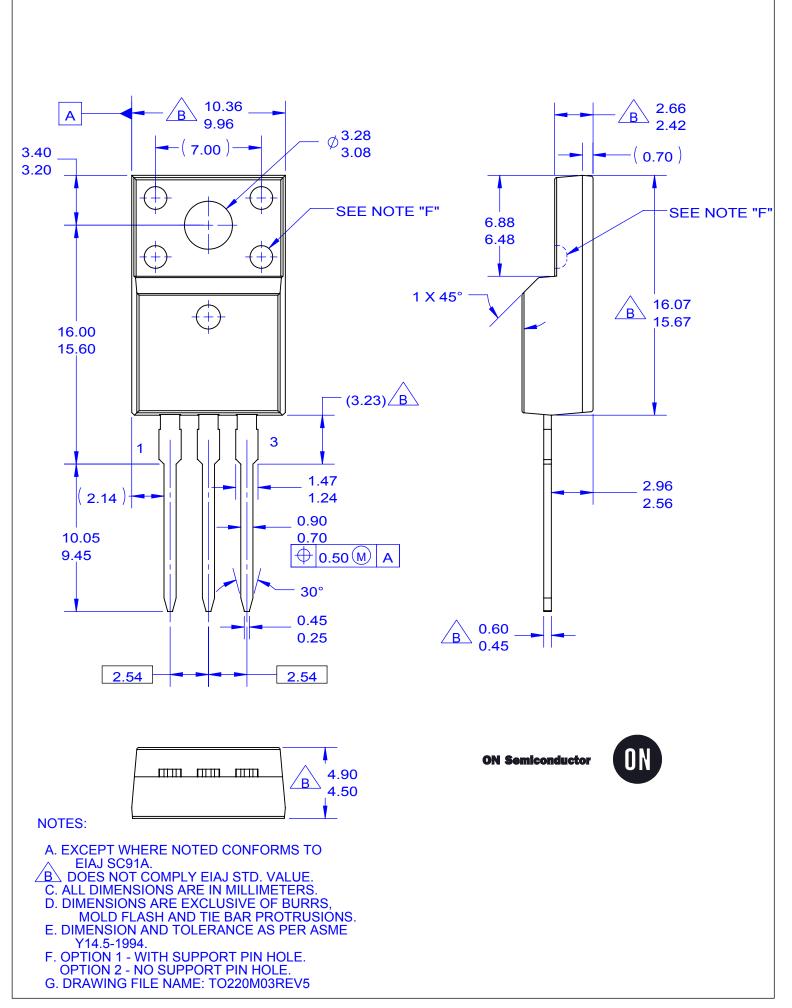
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